

MAIL STOP PCT
IN THE UNITED STATES DESIGNATED OFFICE
OF THE UNITED STATES PATENT AND TRADEMARK OFFICE
UNDER THE PATENT COOPERATION TREATY-CHAPTER II

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INFORMATION DISCLOSURE STATEMENT

APPLICANTS: Distler et al.

ATTORNEY DOCKET NO. P05,0046

INTERNATIONAL APPLICATION NO: PCT/DE2003/002890

INTERNATIONAL FILING DATE: September 1, 2003

10 INVENTION: "METHOD FOR OPERATING A COMPUTED
TOMOGRAPHY APPARATUS HAVING A DIAPHRAGM
AT THE RADIATION DETECTOR" (As Amended)

Commissioner for Patents

P.O. Box 1450

15 Alexandria, Virginia 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. §1.56, Applicants request
that citation and examination of the following documents be made during the
course of examination of the above-referenced application for United States

20 Letters Patent.

AA United States Patent Application Publication No. 2003/0112924

AB United States Patent Application Publication No. 2003/0086534

AC United States Patent No. 6,449,340

AD United States Patent No. 6,396,902

25 AE United States Patent No. 5,644,614

AF United States Patent No. 5,406,611

AG United States Patent No. 5,299,250

AH United States Patent No. 4,691,335

AL German OS 101 45 997

30 AM German OS 38 18 542

EXPLANATION OF RELEVANCE

Reference AF corresponds to German PS 42 26 861 and Reference AH corresponds to European Application 0 187 245, which were identified and discussed in the present specification, together with Reference AD.

5 The aforementioned German counterpart to Reference AF also was cited, together with the German counterpart to Reference AE, and Reference AL, in an examination report rendered by the German Patent and Trademark Office in connection with the counterpart German application.

10 Reference AD also was cited, together with References AC and AG, in the International Search Report rendered during earlier examination of the present PCT application.

References AA, AB and AM are further examples of patents describing radiation detector-proximate, beam-gating diaphragms known to the Applicants.

15 Copies of each of the above references together with Form 1449 are submitted herewith. English translations of References AL and AM are not readily available to the Applicants, however, each of those references has an English language Abstract attached thereto.

20 This Information Disclosure Statement is being filed simultaneously with the present application, and is therefore in compliance with 37 C.F.R. §1.97(b)(1), and no fee is necessary.

All claims of the application are submitted to be patentable over the teachings of the above references, taken singly or in combination. Early consideration of the application is therefore respectfully requested.

Submitted by,

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Form PTO-1449					Docket No. P05,0046		Serial No. New Application	
INFORMATION DISCLOSURE CITATION IN AN APPLICATION (use several sheets if necessary)					Applicant Distler et al.			
					Filing Date Herewith		Group Art Unit Not Yet Assigned	
U.S. PATENT DOCUMENTS								
Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If appropriate	
	AA	2003/0112924	6/19/2003	Seufert				
	AB	2003/0086534	5/8/2003	Seufert				
	AC	6,449,340	9/10/2002	Tybinkowski et al.				
	AD	6,396,902	5/28/2002	Tybinkowski et al.				
	AE	5,644,614	7/1/97	Toth et al.				
	AF	5,406,611	4/11/95	Schobert et al.				
	AG	5,299,250	3/29/94	Styrnol et al.				
	AH	4,691,335	9/1/87	Telorack				
	AI							
	AJ							
	AK							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL	OS 101 45 997	4/10/2003	Germany				
	AM	OS 38 18 542	12/14/89	Germany				
	AN							
	AO							
	AP							
	AQ							
	AR							
	AS							
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)								
	AT							
	AU							
	AV							
	AW							
Examiner				Date Considered				
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>								